

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
		Examiner Gilbert Y. Lee	Art Unit 3673	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,343,792	02-2002	Shinohara et al.	277/355
*	B	US-2002/0117807	08-2002	Yoshida et al.	277/412
	C	US-			
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	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	jp410196801a	07-1998	Japan	Takeshita et al.	F16J015/54
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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